

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YEOH ET AL.	
		Examiner DAVID P. RASHID	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,356,672	03-2002	Feng et al.	382/312
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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